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Application/Control No.	Applicant(s)/Patent under Reexamination
10/730,615	HOWELL ET AL.
Examiner	Art Unit
Jes F. Pascua	3782

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Class	Subclass	Date	Examiner		
383	61.2 203-204 63-64	7/5/2006			
383	updated	1/29/2007			
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